

**Notice of References Cited**

Application/Control No.

10/823,809

Applicant(s)/Patent Under  
Reexamination  
ELBAUM ET AL.

Examiner

Sudhaker B. Patel, D.Sc.Tech.

Art Unit

1624

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	N	2000002851	01-2000	WO	Schindler et al.	
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